


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,325	LEE, JIAHN-LIN	
	Examiner	Art Unit	
	Tai Duong	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	139	12/3/2005	TD
	149		
	151		
	152		
	153		
	154		
	156		
	160		
	190		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
349	139	12/3/05	TD
	153		
	190		
PGPUB text search - 12/03/05, see interference printout		12/3/2005	TD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	12/3/2005	TD